



SN 09/838730

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Tawfik R. Arabi et al.	Examiner:	Russell Kobert
Serial No.:	09/838730	Group Art Unit:	2829
Filed:	April 19, 2001	Docket No.:	884.410US1
Title:	AC TESTING OF LEAKAGE CURRENT IN INTEGRATED CIRCUITS USING RC TIME CONSTANT		
Assignee:	Intel Corporation	Customer No:	21186

AMENDMENT AND RESPONSE UNDER 37 CFR § 1.111

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

This responds to the Office Action mailed on November 5, 2003. Please amend the above-identified patent application as follows.

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